


IEC SYSTEM FOR MUTUAL RECOGNITION OF TEST CERTIFICATES FOR ELECTRICAL EQUIPMENT
(IECEE) CB SCHEME

CB TEST CERTIFICATE

Product	Surface Area Analyzer
Name and address of the applicant	Micromeritics Instrument Corporation 4356 Communications Drive Norcross, GA 30093 United States of America
Name and address of the manufacturer	Micromeritics Instrument Corporation 4356 Communications Drive Norcross, GA 30093 United States of America
Name and address of the factory	<input type="checkbox"/> Additional information on page 2 Micromeritics Instrument Corporation 4356 Communications Drive Norcross, GA 30093 United States of America
Note: When more than one factory, please report on page 2	
Ratings and principal characteristics	100-240Vac, 50/60Hz, 50VA
Trademark (if any)	 mi micromeritics
Customer's Testing Facility (CTF) Stage used	
Model / Type Ref.	Gemini VII
Additional information (if necessary may also be reported on page 2)	<input type="checkbox"/> Additional information on page 2
A sample of the product was tested and found to be in conformity with	IEC 61010-1:2010/AMD1:2016, IEC 61010-2-081:2019 Comments: Refer to the test report for the summary of compliance with National Deviations
As shown in the Test Report Ref. No. which forms part of this Certificate	104568560ATL-001C, 104568560ATL-001D

This CB Test Certificate is issued by the National Certification Body

Intertek Testing Services NA, Inc.
545 E. Algonquin Road, Suite F, Arlington Heights, IL 60005, United States of America